

# N-Channel Dual Cool<sup>TM</sup> 33 PowerTrench<sup>®</sup> MOSFET 30 V, 40 A, 6.25 m $\Omega$

#### Features

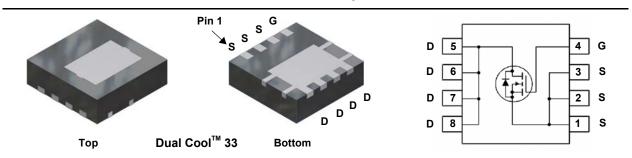
- Dual Cool<sup>TM</sup> Top Side Cooling PQFN package
- Max r<sub>DS(on)</sub> = 6.25 mΩ at V<sub>GS</sub> = 10 V, I<sub>D</sub> = 12 A
- Max r<sub>DS(on)</sub> = 9.0 mΩ at V<sub>GS</sub> = 4.5 V, I<sub>D</sub> = 10 A
- High performance technology for extremely low r<sub>DS(on)</sub>
- RoHS Compliant

## **General Description**

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench<sup>®</sup> process. Advancements in both silicon and Dual Cool<sup>TM</sup> package technologies have been combined to offer the lowest  $r_{DS(on)}$  while maintaining excellent switching performance by extremely low Junction-to-Ambient thermal resistance.

#### Applications

- Synchronous Rectifier for DC/DC Converters
- Telecom Secondary Side Rectification
- High End Server/Workstation



## MOSFET Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter			Ratings	Units	
V <sub>DS</sub>	Drain to Source Voltage			30	V	
V <sub>GS</sub>	Gate to Source Voltage			±20	V	
	Drain Current -Continuous (Package limited)	T <sub>C</sub> = 25 °C		40		
	-Continuous (Silicon limited)	T <sub>C</sub> = 25 °C		70		
Ъ	-Continuous	T <sub>A</sub> = 25 °C	(Note 1a)	17	Α	
	-Pulsed			100		
E <sub>AS</sub>	Single Pulse Avalanche Energy		(Note 3)	60	mJ	
dv/dt	Peak Diode Recovery dv/dt		(Note 4)	1.6	V/ns	
P <sub>D</sub>	Power Dissipation	T <sub>C</sub> = 25 °C		50	14/	
	Power Dissipation	T <sub>A</sub> = 25 °C	(Note 1a)	3.0	W	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature R	ange		-55 to +150	°C	

#### **Thermal Characteristics**

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	(Top Source)	7.9	
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	2.5	
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	42	
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	105	°C/W
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1i)	1i) 17	
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	(Note 1j) 26	
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1k)	12	

### Package Marking and Ordering Information

Device Markin	g Device	Package	Reel Size	Tape Width	Quantity
3020	FDMC3020	DC Dual Cool <sup>TM</sup> 33	13"	12 mm	3000 units

July 2015

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	cteristics					
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	I <sub>D</sub> = 250 μA, V <sub>GS</sub> = 0 V	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C		17		mV/°C
IDSS	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V			1	μA
I <sub>GSS</sub>	Gate to Source Leakage Current	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0 V			±100	nA
On Chara	cteristics					
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250 μA	1.0	1.9	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C		-6		mV/°C
	Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 12 A		5.0	6.25	
r <sub>DS(on)</sub>		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 10 A		7.2	9.0	mΩ
		$V_{GS}$ = 10 V, I <sub>D</sub> = 12 A, T <sub>J</sub> = 125 °C		7.5	9.1	
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 12 A		44		S
Dynamic C <sub>iss</sub>	Characteristics			1038	1385	pF
C <sub>iss</sub> C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V,		513	685	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	f = 1 MHz		87	135	pF
R <sub>g</sub>	Gate Resistance		0.1	0.9	2.0	Ω
•	Characteristics					
t <sub>d(on)</sub>	Turn-On Delay Time			9	18	ns
t <sub>r</sub>	Rise Time	V <sub>DD</sub> = 15 V, I <sub>D</sub> = 12 A,		3	10	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$		19	35	ns
t <sub>f</sub>	Fall Time			2	10	ns
Qg	Total Gate Charge	V <sub>GS</sub> = 0 V to 10 V		15.5	23	nC
Q <sub>g</sub>	Total Gate Charge	$V_{GS} = 0 V \text{ to } 4.5 V V_{DD} = 15 V,$		7.1	10.6	nC
Q <sub>gs</sub>	Gate to Source Gate Charge	I <sub>D</sub> = 12 A		3		nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge			2.5		nC
Drain-Soເ	urce Diode Characteristics					
V	Source to Drain Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 12 A (Note 2)		0.82	1.3	v
V <sub>SD</sub>		V <sub>GS</sub> = 0 V, I <sub>S</sub> = 1.9 A (Note 2)		0.73	1.2	v
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 12 A, di/dt = 100 A/μs		25	45	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$F = 12 \text{ A}, \text{ u/ul} = 100 \text{ A/}\mu\text{S}$		9	18	nC

FDMC3020DC N-Channel Dual Cool<sup>TM</sup> 33 PowerTrench<sup>®</sup> MOSFET

## **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Top Source)	7.9	
$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	2.5	
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	42	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	105	
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient	(Note 1c)	29	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1d)	40	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1e)	19	°C 144
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient	(Note 1f)	23	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1g)	30	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1h)	79	
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient (Note 1i)		17	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1j) 26		
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1k)	12	
R <sub>0JA</sub>	Thermal Resistance, Junction to Ambient	(Note 1I)	16	

NOTES:

1. R<sub>0,1</sub>/s determined with the device mounted on a FR-4 board using a specified pad of 2 oz copper as shown below. R<sub>0,1C</sub> is guaranteed by design while R<sub>0CA</sub> is determined by the user's board design.



a. 42 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b. 105 °C/W when mounted on a minimum pad of 2 oz copper

c. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in^2 pad of 2 oz copper

d. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper

e. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper

f. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper

g. 200FPM Airflow, No Heat Sink,1 in<sup>2</sup> pad of 2 oz copper

h. 200FPM Airflow, No Heat Sink, minimum pad of 2 oz copper

i. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper

j. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper

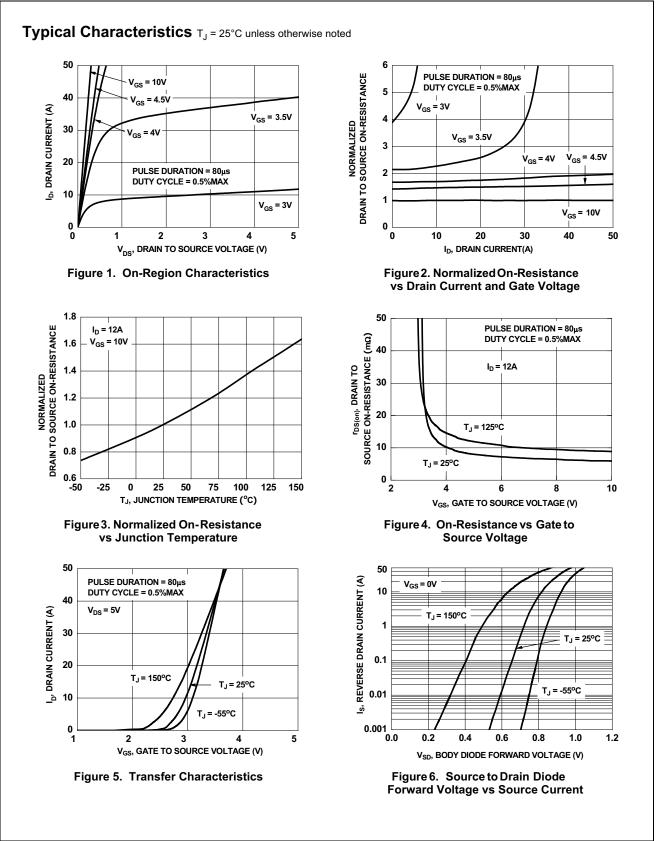
k. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper

I. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper

2. Pulse Test: Pulse Width < 300  $\mu s,$  Duty cycle < 2.0%.

3. E<sub>AS</sub> of 60 mJ is based on starting T<sub>J</sub> = 25 °C, L = 1 mH, I<sub>AS</sub> = 11 A, V<sub>DD</sub> = 27 V, V<sub>GS</sub> = 10 V.

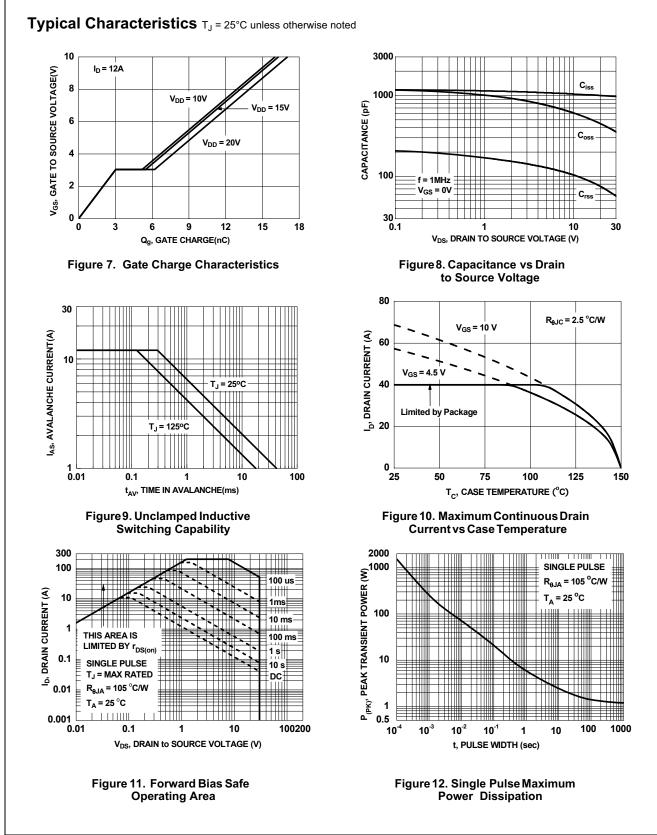
4.  $I_{SD} \leq$  12 A, di/dt  $\leq$  100 A/µs,  $V_{DD} \leq$  BV\_{DSS}, Starting  $T_J$  = 25  $^oC.$ 



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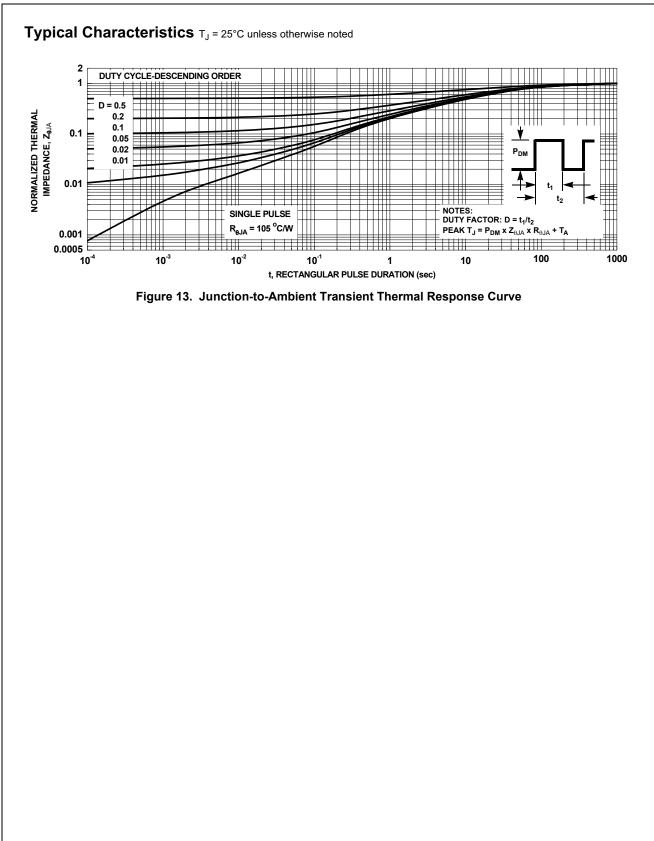


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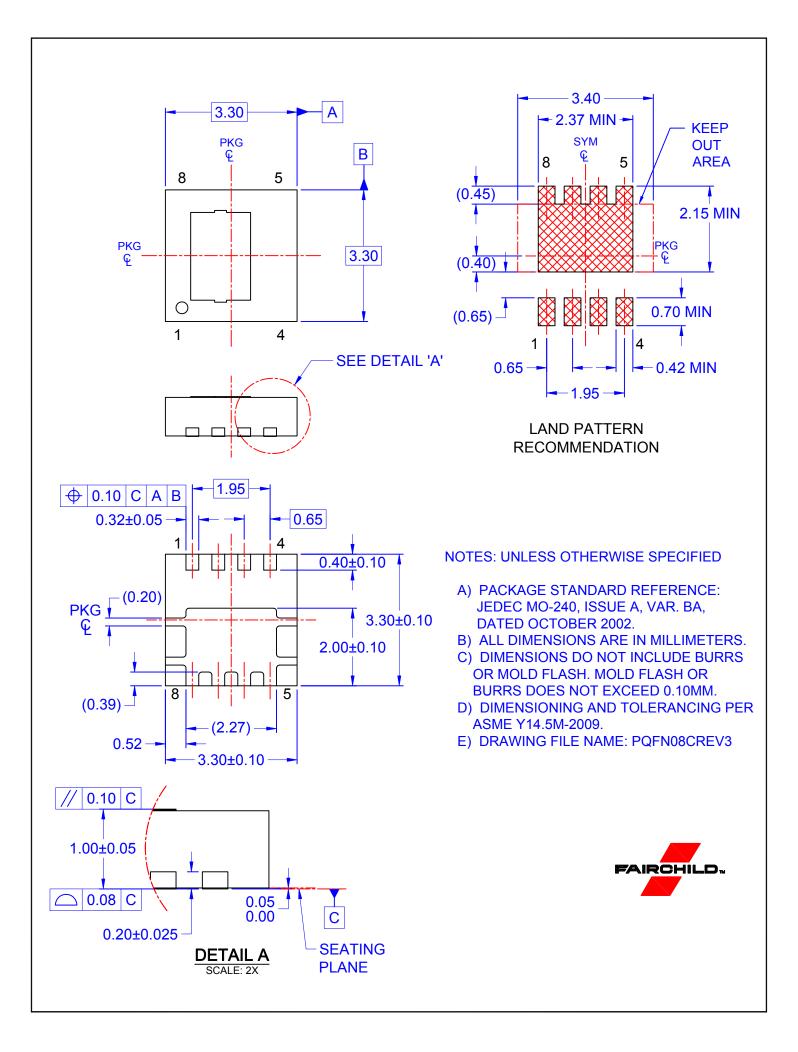
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